

8961726 TEXAS INSTR (OPTO)

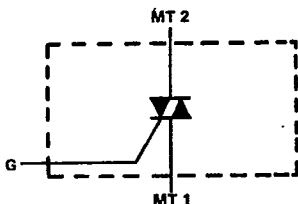
62C 36714 D

TIC216A, TIC216B, TIC216C, TIC216D,
TIC216E, TIC216M, TIC216S, TIC216N
SILICON TRIACS
REVISED OCTOBER 1984

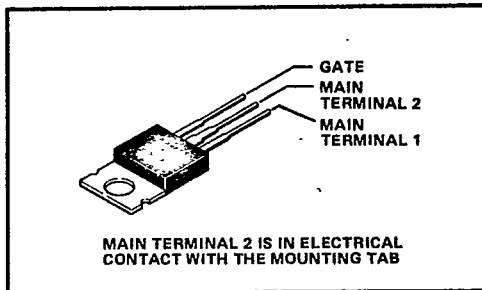
T-25-15

- Sensitive-Gate Triacs
- 100 V to 800 V
- MAX I_{GT} of 5 mA (Quadrants 1-3)

device schematic



TO-220AB PACKAGE



absolute maximum ratings at 25°C case temperature (unless otherwise noted)

	TIC216A	TIC216B	TIC216C	TIC216D
Repetitive peak off-state voltage, V _{DRM} (see Note 1)	100 V	200 V	300 V	400 V
Full-cycle RMS on-state current at (or below) 70°C case temperature I _{T(RMS)} (see Note 2)	6 A			
Peak on-state surge current, full sine wave, I _{TSM} (see Note 3)	60 A			
Peak on-state surge current half sine wave, I _{TSM} (see Note 4)	70 A			
Peak gate current, I _{GM}	1 A			
Peak gate power dissipation, P _{GM} , at (or below) 70°C case temperature (pulse duration < 200 μs)	2.2 W			
Average gate power dissipation, P _{G(av)} , at (or below) 70°C case temperature (see Note 5)	0.9 W			
Operating case temperature range	- 40°C to 110°C			
Storage temperature range	- 40°C to 125°C			
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	230°C			

- NOTES:
1. These values apply bidirectionally for any value of resistance between the gate and Main Terminal 1.
 2. This value applies for 50-Hz full sine wave operation with resistive load. Above 70°C derate linearly to 110°C case temperature at the rate of 150 mW/°C.
 3. This value applies for one 50-Hz full sine wave when the device is operating at (or below) the rated value of on-state current. Surge may be repeated after the device has returned to original thermal equilibrium. During the surge, gate control may be lost.
 4. This value applies for one 50-Hz half sine wave when the device is operating at (or below) the rated value of on-state current. Surge may be repeated after the device has returned to original thermal equilibrium. During the surge gate control may be lost.
 5. This value applies for a maximum averaging time of 20 ms.

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TIC Devices

8961726 TEXAS INSTR (OPT0)

62C 36715 D

T-25-15

TIC216A, TIC216B, TIC216C, TIC216D,
TIC216E, TIC216M, TIC216S, TIC216N
SILICON TRIACS

absolute maximum ratings at 25°C case temperature (unless otherwise noted)

	TIC216E	TIC216M	TIC216S	TIC216N
Repetitive peak off-state voltage, V_{DRM} (see Note 1)	500 V	600 V	700 V	800 V
Full-cycle RMS on-state current at (or below) 70°C case temperature, $I_T(RMS)$ (see Note 2)	6 A			
Peak on-state surge current, full sine wave, I_{TSM} (see Note 3)	60 A			
Peak on-state surge current half sine wave, I_{TSM} (see Note 4)	70 A			
Peak gate current, I_{GM}	1 A			
Peak gate power dissipation, P_{GM} , at (or below) 70°C case temperature (pulse duration $\leq 200 \mu s$)	2.2 W			
Average gate power dissipation, $P_{G(av)}$, at (or below) 70°C case temperature (see Note 5)	0.9 W			
Operating case temperature range	-40°C to 110°C			
Storage temperature range	-40°C to 125°C			
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	230°C			

- NOTES: 1. These values apply bidirectionally for any value of resistance between the gate and Main Terminal 1.
2. This value applies for 50-Hz full sine wave operation with resistive load. Above 70°C derate linearly to 110°C case temperature at the rate of 100 mW/°C.
3. This value applies for one 50-Hz full sine wave when the device is operating at (or below) the rated value of on-state current. Surge may be repeated after the device has returned to original thermal equilibrium. During the surge gate control may be lost.
4. This value applies for one 50-Hz half sine wave when the device is operating at (or below) the rated value of on-state current. Surge may be repeated after the device has returned to original thermal equilibrium. During the surge gate control may be lost.
5. This value applies for a maximum averaging time of 20 ms.

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TIC Devices

8961726 TEXAS INSTR (OPTO)

62C 36716 D

TIC216A, TIC161B, TIC161C, TIC161D,
TIC216E, TIC216M, TIC216S, TIC216N
SILICON TRIACS

electrical characteristics at 25°C case temperature (unless otherwise noted)

7-25-15

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I _{DRM}	Repetitive Peak Off-State Current	V _{DRM} = Rated V _{DRM} , I _G = 0, T _C = 110°C			± 2	mA
I _{GTM}	Peak Gate Trigger Current	V _{supply} = +12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs			5	mA
		V _{supply} = +12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs			-5	
		V _{supply} = -12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs			-5	
		V _{supply} = -12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs			10	
V _{GTM}	Peak Gate Trigger Voltage	V _{supply} = +12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs			2.2	V
		V _{supply} = +12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs			-2.2	
		V _{supply} = -12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs			-2.2	
		V _{supply} = -12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs			3	
V _{TM}	Peak On-State Voltage	I _{TM} = 8.4 A, I _G = 50 mA, See Note 6			± 1.7	mA
I _H	Holding Current	V _{supply} = +12 V [†] , I _{TM} = 100 mA, I _G = 0			+ 30	mA
		V _{supply} = -12 V [†] , I _{TM} = -100 mA, I _G = 0			- 30	
I _L	Latching Current	V _{supply} = +12 V [†] , See Note 7			50	mA
		V _{supply} = -12 V [†] , See Note 7			- 20	
dv/dt	Critical Rate of Rise of Off-State Voltage	V _{DRM} = Rated V _{DRM} , I _G = 0, T _C = 110°C			50	V/μs
dv/dt(c)	Critical Rise of Commutation Voltage	V _{DRM} = Rated V _{DRM} , I _{TRM} = ± 8.4 A, T _C = 70°C			5	V/μs

† All voltages are with respect to Main Terminal 1.

- NOTES: 6. These parameters must be measured using pulse techniques, t_w < 1 ms, duty cycle < 2 %. Voltage-sensing contacts, separate from the current-carrying contacts, are located within 3,2 mm (1/8 inch) from the device body.
7. The triacs are triggered by a 15-V (open-circuit amplitude) pulse supplied by a generator with the following characteristics: R_G = 100 Ω, t_w = 20 μs, t_r < 15 ns, t_f < 15 ns, f = 1 kHz.

thermal characteristics

PARAMETER	MIN	TYP	MAX	UNIT
R _{θJC}			2.5	°C/W
R _{θJA}			62.5	



TIC Devices